

<b>Notice of References Cited</b>	Application/Control No. 10/781,968	Applicant(s)/Patent Under Reexamination SABLAK, SEZAI	
	Examiner Yogesh K. Aggarwal	Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0183917	09-2004	von Flotow et al.	348/208.99
*	B	US-6,809,758	10-2004	Jones, Paul W.	348/208.99
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

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